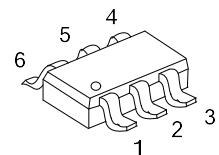


SINGLE 3-INPUT POSITIVE-NOR GATE

■ DESCRIPTION

The U74LVC1G27 device performs the Boolean function $Y=A+B+C$ or $Y=\bar{A}\bar{B}\bar{C}$ in positive logic.

This device is fully specified for partial-power-down applications using I_{OFF} . The I_{OFF} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.



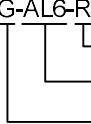
SOT-363

■ FEATURES

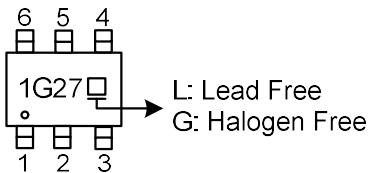
- * Wide supply voltage range from 1.65V to 5.5V
- * Inputs accept voltages up to 5.5V
- * I_{OFF} supports live insertion, partial-power-down mode, back-drive protection
- * Supports Down Translation to V_{CC}
- * Low static power consumption; $I_{CC}=\pm 10\mu A$ (Max.)
- * $\pm 24mA$ Output Drive at 3.3V

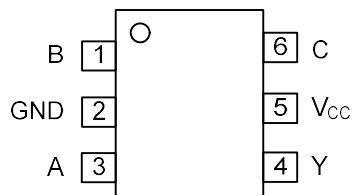
■ ORDERING INFORMATION

Ordering Number		Package	Packing
Lead Free	Halogen Free		
U74LVC1G27L-AL6-R	U74LVC1G27G-AL6-R	SOT-363	Tape Reel

U74LVC1G27G-AL6-R 	(1)R: Tape Reel (2)AL6: SOT-363 (3)G: Halogen Free and Lead Free, L: Lead Free
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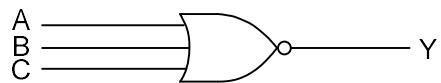
■ MARKING



■ PIN CONFIGURATION**■ FUNCTION TABLE**

INPUT			OUTPUT
A	B	C	Y
H	X	X	L
X	H	X	L
X	X	H	L
L	L	L	H

Note: H: HIGH voltage level, L: LOW voltage level, X = Valid H or L

■ LOGIC DIAGRAM (positive logic)

■ **ABSOLUTE MAXIMUM RATING** ($T_A=25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	CONDITIONS	RATINGS	UNIT
Supply Voltage	V_{CC}		-0.5 ~ +6.5	V
Input Voltage	V_{IN}		-0.5 ~ +6.5	V
Output Voltage	V_{OUT}	Output in the high or low state	-0.5 ~ $V_{CC}+0.5$	V
		Output in the power-off state	-0.5 ~ +6.5	V
Continuous V_{CC} or GND Current	I_{CC}		± 100	mA
Continuous Output Current	I_{OUT}		± 50	mA
Input Clamp Current	I_{IK}	$V_{IN}<0\text{V}$	-50	mA
Output Clamp Current	I_{OK}	$V_{OUT}<0\text{V}$	-50	mA
Storage Temperature Range	T_{STG}		-65 ~ +150	$^\circ\text{C}$

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ **RECOMMENDED OPERATING CONDITIONS** ($T_A=25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Supply Voltage	V_{CC}	Operating	1.65		5.5	V
		Data retention only	1.5			V
Input Voltage	V_{IN}		0		5.5	V
Output Voltage	V_{OUT}		0		V_{CC}	V
Input Transition Rise or Fall Rate	$\Delta t/\Delta v$	$V_{CC}=1.8\text{V}\pm 0.15\text{V}, 2.5\text{V}\pm 0.2\text{V}$			20	ns/V
		$V_{CC}=3.3\text{V}\pm 0.3\text{V}$			10	ns/V
		$V_{CC}=5\text{V}\pm 0.5\text{V}$			10	ns/V
Operating Temperature	T_A		-40		+125	$^\circ\text{C}$

■ **ELECTRICAL CHARACTERISTICS** (Unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	$T_A=25^\circ\text{C}$			$T_A=-40^\circ\text{C}\sim+125^\circ\text{C}$			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
High-level Input Voltage	V_{IH}	$V_{CC}=1.8\pm 0.15\text{V}$	0.65× V_{CC}			0.65× V_{CC}			V
		$V_{CC}=2.5\pm 0.2\text{V}$	1.7			1.7			V
		$V_{CC}=3.3\pm 0.3\text{V}$	2			2			V
		$V_{CC}=5\pm 0.5\text{V}$	0.7× V_{CC}			0.7× V_{CC}			V
Low-level Input Voltage	V_{IL}	$V_{CC}=1.8\pm 0.15\text{V}$			0.35× V_{CC}			0.35× V_{CC}	V
		$V_{CC}=2.5\pm 0.2\text{V}$			0.7			0.7	V
		$V_{CC}=3.3\pm 0.3\text{V}$			0.8			0.8	V
		$V_{CC}=5\pm 0.5\text{V}$			0.3× V_{CC}			0.3× V_{CC}	V
High-Level Output Voltage	V_{OH}	$V_{CC}=1.65 \sim 5.5\text{V}, I_{OH}=-100\mu\text{A}$	$V_{CC}-0.1$			$V_{CC}-0.1$			V
		$V_{CC}=1.65\text{V}, I_{OH}=-4\text{mA}$	1.2			0.95			V
		$V_{CC}=2.3\text{V}, I_{OH}=-8\text{mA}$	1.9			1.7			V
		$V_{CC}=3.0\text{V}, I_{OH}=-16\text{mA}$	2.4			2.2			V
		$V_{CC}=3.0\text{V}, I_{OH}=-24\text{mA}$	2.3			2.0			V
		$V_{CC}=4.5\text{V}, I_{OH}=-32\text{mA}$	3.8			3.4			V

■ ELECTRICAL CHARACTERISTICS (Cont.)

PARAMETER	SYMBOL	TEST CONDITIONS	$T_A=25^\circ C$			$T_A=-40^\circ C \sim +125^\circ C$			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
Low-Level Output Voltage	V_{OL}	$V_{CC}=1.65 \sim 5.5V, I_{OL}=100\mu A$			0.1			0.1	V
		$V_{CC}=1.65V, I_{OL}=4mA$			0.45			0.7	V
		$V_{CC}=2.3V, I_{OL}=8mA$			0.3			0.45	V
		$V_{CC}=3.0V, I_{OH}=16mA$			0.4			0.6	V
		$V_{CC}=3.0V, I_{OH}=24mA$			0.55			0.8	V
		$V_{CC}=4.5V, I_{OL}=32mA$			0.55			0.8	V
Input Leakage Current (All Input)	$I_{I(LEAK)}$	$V_{CC}=0V \sim 5.5V$ $V_{IN}=5.5V \text{ or GND}$			± 5			± 5	μA
Power Off Leakage Current	I_{OFF}	$V_{CC}=0V, V_{IN} \text{ or } V_{OUT}=5.5V$			± 10			± 10	μA
Quiescent Supply Current	I_{CC}	$V_{CC}=1.65 \sim 5.5V,$ $V_{IN}=5.5V \text{ or GND}, I_{OUT}=0$			10			10	μA
Additional Quiescent Supply Current Per Input Pin	ΔI_{CC}	$V_{CC}=3 \sim 5.5V, \text{ One input at } V_{CC}-0.6V, \text{ other inputs at } V_{CC} \text{ or GND}$			500			500	μA

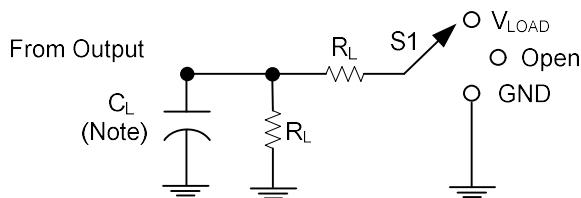
■ SWITCHING CHARACTERISTICS (Unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	$T_A=25^\circ C$			$T_A=-40^\circ C \sim +125^\circ C$			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
Propagation delay from input (A, B or C) to output (Y)	t_{PD}	$V_{CC}=1.8V \pm 0.15V$	$C_L=15pF$	2	18.2	1		20	ns
		$V_{CC}=2.5V \pm 0.2V$		1.2	8	1		9.5	ns
		$V_{CC}=3.3V \pm 0.3V$		1	6	1		7.5	ns
		$V_{CC}=5V \pm 0.5V$		0.8	4.5	0.5		5.5	ns
		$V_{CC}=1.8V \pm 0.15V$	$C_L=30pF \text{ or } 50pF$	2.2	20.5	1		23.3	ns
		$V_{CC}=2.5V \pm 0.2V$		1.4	9.5	1		11	ns
		$V_{CC}=3.3V \pm 0.3V$		1.3	7.5	1		9	ns
		$V_{CC}=5V \pm 0.5V$		1	5.5	1		6.5	ns

■ OPERATING CHARACTERISTICS ($T_A=25^\circ C$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Input Capacitance	C_{IN}	$V_{CC}=3.3V, V_{IN}=V_{CC} \text{ or GND}$		3.5		pF
Power Dissipation Capacitance	C_{PD}	$V_{CC}=1.8V, f=10MHz$		17		pF
		$V_{CC}=2.5V, f=10MHz$		18		pF
		$V_{CC}=3.3V, f=10MHz$		19		pF
		$V_{CC}=5V, f=10MHz$		22		pF

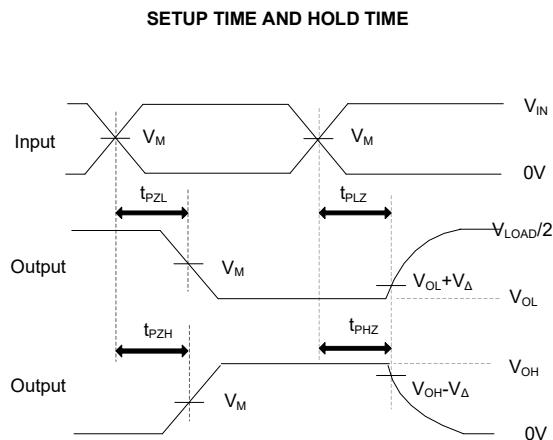
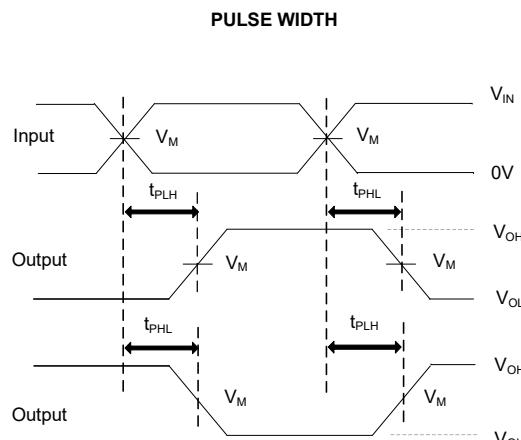
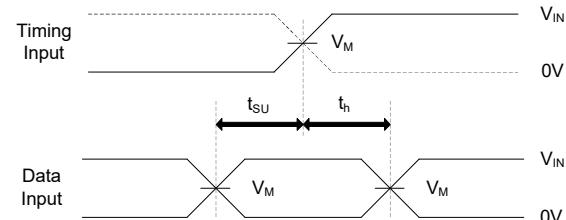
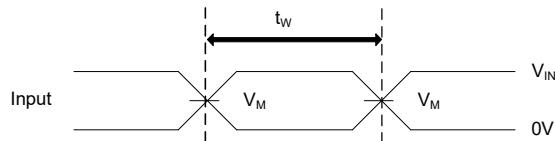
■ TEST CIRCUIT AND WAVEFORMS



TEST	S1
t_{PLH}/t_{PHL}	Open
t_{PLZ}/t_{PZL}	V_{LOAD}
t_{PHZ}/t_{PZH}	GND

Note: C_L includes probe and jig capacitance.

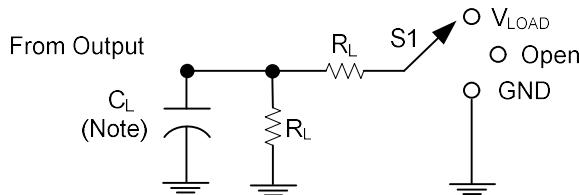
V_{CC}	Inputs		V_M	V_{LOAD}	C_L	R_L	V_Δ
	V_{IN}	t_R / t_F					
$1.8V \pm 0.15V$	V_{CC}	$\leq 2ns$	$V_{CC}/2$	$2 \times V_{CC}$	15pF	$1M\Omega$	0.15V
$2.5V \pm 0.2V$	V_{CC}	$\leq 2ns$	$V_{CC}/2$	$2 \times V_{CC}$	15pF	$1M\Omega$	0.15V
$3.3V \pm 0.3V$	3V	$\leq 2.5ns$	1.5V	6V	15pF	$1M\Omega$	0.3V
$5V \pm 0.5V$	V_{CC}	$\leq 2.5ns$	$V_{CC}/2$	$2 \times V_{CC}$	15pF	$1M\Omega$	0.3V



Notes: 1. C_L includes probe and jig capacitance.

2. All input pulses are supplied by generators having the following characteristics: PRR $\leq 10MHz$, $Z_O = 50\Omega$.

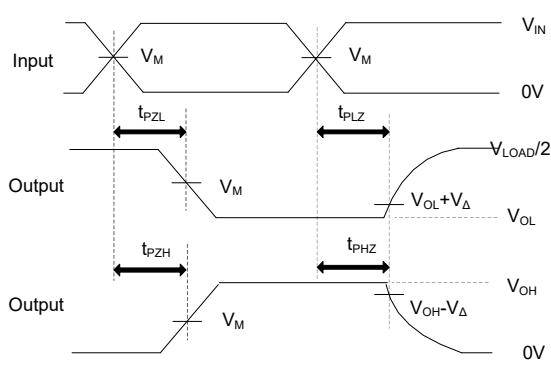
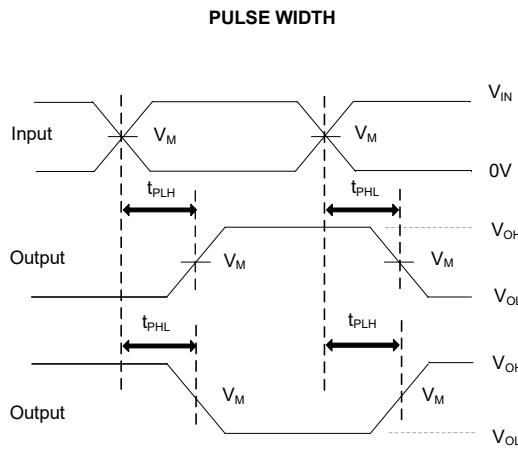
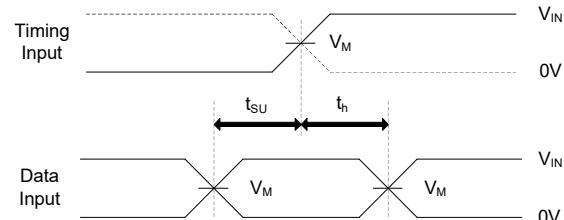
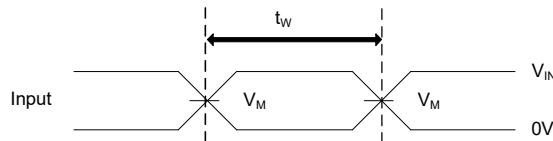
■ TEST CIRCUIT AND WAVEFORMS (Cont.)



TEST	S1
t_{PLH}/t_{PHL}	Open
t_{PLZ}/t_{PZL}	V_{LOAD}
t_{PHZ}/t_{PZH}	GND

Note: C_L includes probe and jig capacitance.

V_{CC}	Inputs		V_M	V_{LOAD}	C_L	R_L	V_Δ
	V_{IN}	t_R / t_F					
$1.8V \pm 0.15V$	V_{CC}	$\leq 2ns$	$V_{CC}/2$	$2 \times V_{CC}$	30pF	$1K\Omega$	0.15V
$2.5V \pm 0.2V$	V_{CC}	$\leq 2ns$	$V_{CC}/2$	$2 \times V_{CC}$	30pF	500Ω	0.15V
$3.3V \pm 0.3V$	3V	$\leq 2.5ns$	1.5V	6V	50pF	500Ω	0.3V
$5V \pm 0.5V$	V_{CC}	$\leq 2.5ns$	$V_{CC}/2$	$2 \times V_{CC}$	50pF	500Ω	0.3V



Notes: 1. C_L includes probe and jig capacitance.

2. All input pulses are supplied by generators having the following characteristics: PRR $\leq 10MHz$, $Z_O = 50\Omega$.

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